


<b>Search Notes</b> 	<b>Application/Control No.</b> 10579575	<b>Applicant(s)/Patent Under Reexamination</b> LESCUYER ET AL.
	<b>Examiner</b> Kyung H Shin	<b>Art Unit</b> 2443

SEARCHED			
Class	Subclass	Date	Examiner
709	224, 223, 228	4-25-10	KHS
370	392	4-25-10	KHS

SEARCH NOTES		
Search Notes	Date	Examiner
inventor names	4-25-10	KHS
EAST search Rpt included	4-25-10	KHS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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